

规格书编号

SPEC NO:

产品规格书 SPECIFICATION

CUSTOMER 客 户:						
PRODUCT 产品:	SAW FILTER					
MODEL NO 型 号:	HDF821A F11					
PREPARED 编 制:	CHECKED 审 核:					
APPROVED 批准:	DATE 日期]: 2006-5-11				
定点性》 CHEMONED DECEMBED						
客户确认 CUSTOMER RECEIVED:						
审核 CHECKED	批准 APPROVED	日期 DATE				

无锡市好达电子有限公司 Shoulder Electronics Limited





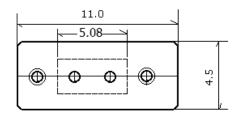
更改历史记录 History Record

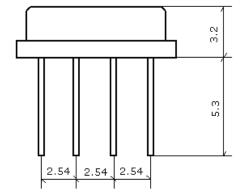
更改日期 Date	规格书编号 Spec. No.	产品型号 Part No.	客户产品型号 Customer No.	更改内容描述 Modify Content	备注 Remark



1. Package Dimension

Unit:mm







2. Marking HD F821A

2.1 Color: Black or Blue

2.2 821: Center Frequency(MHz)

3.Performance

3.1Application

Low-Loss SAW Filter of cordless system.

Center Frequency:821MHz

3.2Maximum Rating

Operation Temperature Range	-40°C to +85°C
Storage Temperature Range	-40°C to +85°C
DC. Permissive Voltage	0 V DC. max.
Maximum Input Power	5 dBm

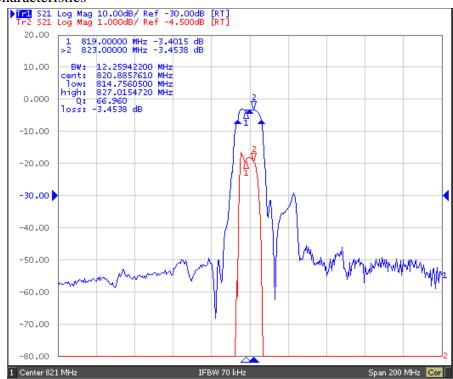


SAW FILTER

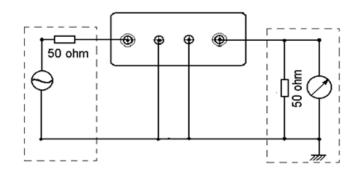
3.3 Electronic Characteristics

Item	Specification	
Center Frequency(fo)	821 MHz	
Insertion Loss(dB)		
1.819-823 MHz	4.5max	
2.)770-780 MHz	40 min	
3.)795-800 MHz	30 min	
4.)841-850 MHz	20 min	
5.)866~900MHz	40 min	
Ripple deviation (819-823MHz)(dB)	1.5max	
Input/output Impedance(Nominal)	50 Ω	

3.4 Frequency Characteristics



3.5 Test Circuit





SAW FILTER

4. ENVIRONMENTAL CHARACTERISTICS

4-1 High temperature exposure

Subject the device to $+85^{\circ}$ C for 16 hours. Then release the filter into the room conditions for 24 hours prior to the measurement. It shall fulfill the specifications in 3.3.

4-2 Low temperature exposure

Subject the device to -40° C for 16 hours. Then release the device into the room conditions for 24 hours prior to the measurement. It shall fulfill the specifications in 3.3.

4-3 Temperature cycling

Subject the device to a low temperature of -40° C for 30 minutes. Following by a high temperature of $+80^{\circ}$ C for 30 Minutes. Then release the device into the room conditions for 24 hours prior to the measurement. It shall meet the specifications in 3.3.

4-4 Resistance to solder heat

Dip the device terminals no closer than 1.5mm into the solder bath at 260° C $\pm 10^{\circ}$ C for 10 ± 1 sec. Then release the device into the room conditions for 4 hours. The device shall meet the specifications in 3.3.

4-5 Solderability

Subject the device terminals into the solder bath at 245° C $\pm 5^{\circ}$ C for 5s, More than 95% area of the terminals must be covered with new solder. It shall meet the specifications in 3.3.

4-6 Mechanical shock

Drop the device randomly onto the concrete floor from the height of 1m 3 times. the device shall fulfill the specifications in 3.3.

4-7 Vibration

Subject the device to the vibration for 1 hour each in x,y and z axes with the amplitude of 1.5 mm at 10 to 55 Hz. The device shall fulfill the specifications in 3.3.

5. REMARK

5.1 Static voltage

Static voltage between signal load & ground may cause deterioration &destruction of the component. Please avoid static voltage.

5.2 Ultrasonic cleaning

Ultrasonic vibration may cause deterioration & destruction of the component. Please avoid ultrasonic cleaning

5.3 Soldering

Only leads of component may be soldered . Please avoid soldering another part of component.